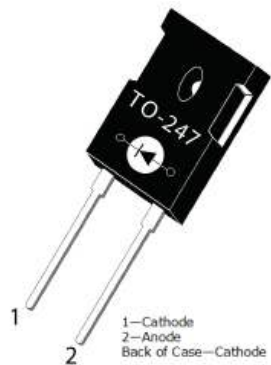


APT30D60BG Fast Soft Recovery Rectifier Diode

Product Overview

The APT30D60BG device is a 600 V, 30 A Fast Soft Recovery Rectifier Si Diode in a TO-247 package.



Features

The following are key features of the APT30D60BG device:

- Fast recovery times
- Soft recovery characteristics
- Low forward voltage
- Low leakage current
- RoHS compliant

Benefits

The following are benefits of the APT30D60BG device:

- Low switching losses
- Low noise (EMI) switching
- Cooler operation
- Higher reliability systems
- Increased system power density

Applications

The APT30D60BG device is designed for the following applications:

- Power factor correction (PFC)
- Anti-parallel diode
 - Switch-mode power supply
 - Inverters
- Freewheeling diode
 - Motor controllers
 - Inverters/converters
- Snubber diode

Device Specifications

This section shows the specifications of the APT30D60BG device.

Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the APT30D60BG device.

$T_C = 25\text{ }^\circ\text{C}$, unless otherwise specified.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
V_R	Maximum DC reverse voltage	600	V
V_{RRM}	Maximum peak repetitive reverse voltage		
V_{RWM}	Maximum working peak reverse voltage		
$I_{F(AV)}$	Maximum average forward current ($T_C = 140\text{ }^\circ\text{C}$, duty cycle = 0.5)	30	A
I_{FSM}	Non-repetitive forward surge current ($T_J = 45\text{ }^\circ\text{C}$, 8.3 ms)	320	

The following table shows the thermal and mechanical characteristics of the APT30D60BG device.

Table 2 • Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Typ	Max	Unit
$R_{\theta JC}$	Junction-to-case thermal resistance			0.67	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-ambient thermal resistance			40	
T_J, T_{STG}	Operating and storage temperature range	-55		175	$^\circ\text{C}$
T_L	Lead temperature for 10 seconds			300	
Wt	Package weight		0.22		oz
			6.2		g
	Mounting torque, 6-32 or M3 screw			10	lbf•m
				1.1	N•m

Electrical Performance

The following table shows the static characteristics of the APT30D60BG device. $T_J = 25\text{ }^\circ\text{C}$, unless otherwise specified.

Table 3 • Static Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_F	Forward voltage	$I_F = 30\text{ A}$		1.6	1.8	V
		$I_F = 60\text{ A}$		1.9		
		$I_F = 30\text{ A}, T_J = 125\text{ }^\circ\text{C}$		1.4		
I_{RM}	Maximum reverse leakage current	$V_R = V_R\text{ rated}$			250	μA
		$V_R = V_R\text{ rated}, T_J = 125\text{ }^\circ\text{C}$			500	
C_J	Junction capacitance	$V_R = 200\text{ V}$		44		pF

The following table shows the dynamic characteristics of the APT30D60BG device.

Table 4 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
t_{rr}	Reverse recovery time	$I_F = 1\text{ A}, di_F/dt = -100\text{ A}/\mu\text{s}$ $V_R = 30\text{ V}$		23		ns
t_{rr}	Reverse recovery time	$I_F = 30\text{ A}, di_F/dt = -200\text{ A}/\mu\text{s}$ $V_R = 400\text{ V}$		85		ns
Q_{rr}	Reverse recovery charge			130		nC
I_{RRM}	Maximum reverse recovery current			4		A
t_{rr}	Reverse recovery time	$I_F = 30\text{ A}, di_F/dt = -200\text{ A}/\mu\text{s}$ $V_R = 400\text{ V}, T_J = 125\text{ }^\circ\text{C}$		160		ns
Q_{rr}	Reverse recovery charge			700		nC
I_{RRM}	Maximum reverse recovery current			8		A
t_{rr}	Reverse recovery time	$I_F = 30\text{ A}, di_F/dt = -1000\text{ A}/\mu\text{s}$ $V_R = 400\text{ V}, T_J = 125\text{ }^\circ\text{C}$		70		ns
Q_{rr}	Reverse recovery charge			1300		nC
I_{RRM}	Maximum reverse recovery current			30		A

Typical Performance Curves

This section shows the typical performance curves of the APT30D60BG device.

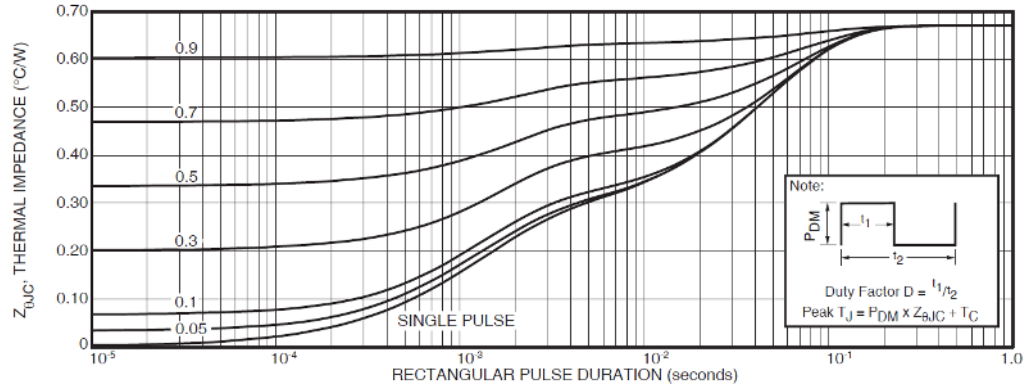


Figure 1 • Maximum Transient Thermal Impedance

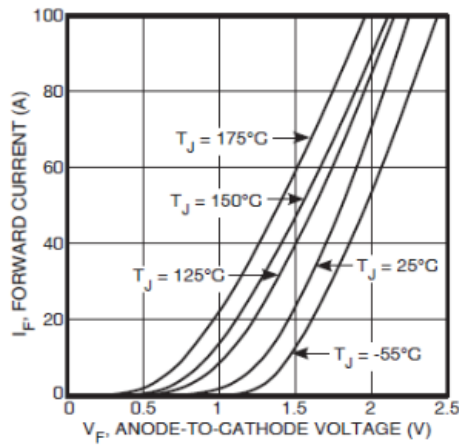


Figure 2 • Forward Current vs. Forward Voltage

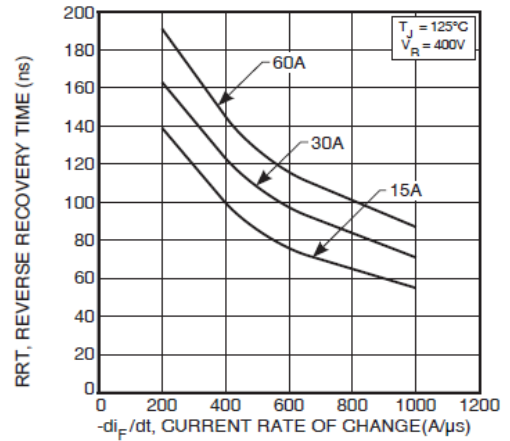


Figure 3 • Reverse Recovery Time vs. Current Rate of Change

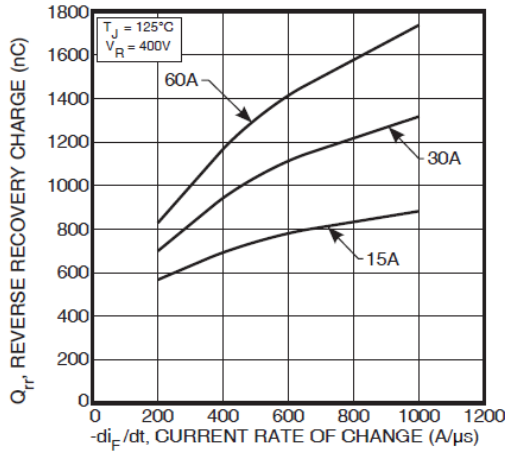


Figure 4 • Reverse Recovery Charge vs. Current Rate of Change

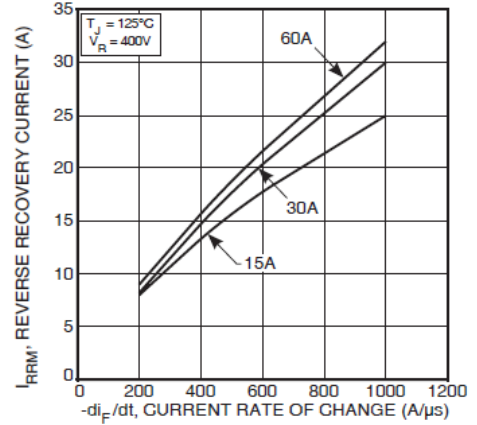


Figure 5 • Reverse Recovery Current vs. Current Rate of Change

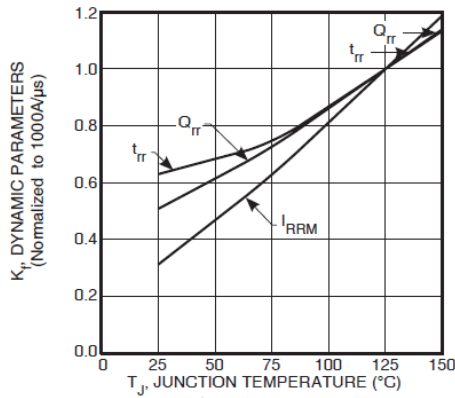


Figure 6 • Dynamic Parameters vs. Junction Temperature

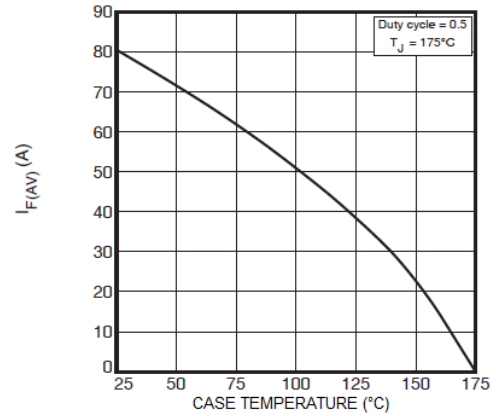


Figure 7 • Maximum Average Forward Current vs. Case Temperature

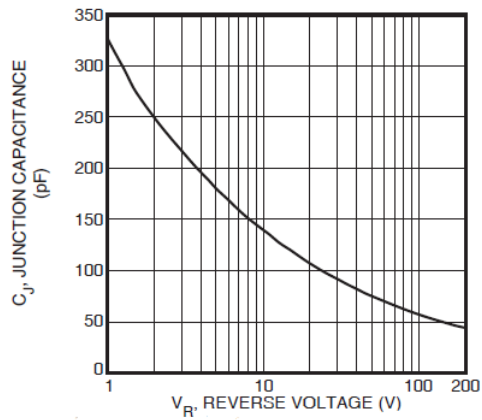


Figure 8 • Junction Capacitance vs. Reverse Voltage

Reverse Recovery Overview

The following figure illustrates the diode test circuit of the APT30D60BG device.

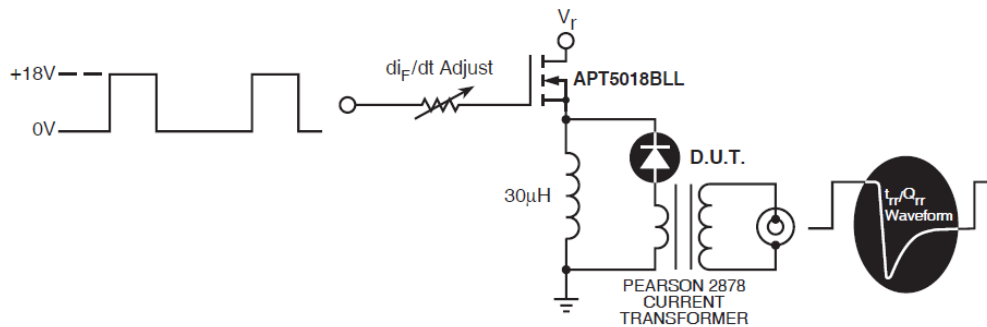


Figure 9 • Diode Test Circuit

The following figure illustrates the diode reverse recovery waveform and definitions of the APT30D60BG device.

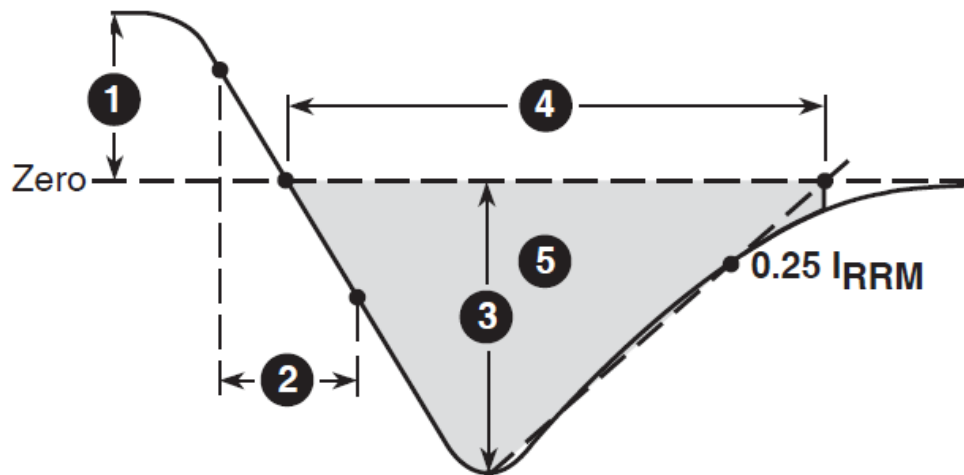


Figure 10 • Diode Reverse Recovery Waveform and Definitions

1. I_F —Forward conduction current.
2. di_F/dt —Rate of diode current change through zero crossing.
3. I_{RRM} —Maximum reverse recovery current.
4. t_{rr} —Reverse recovery time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and $0.25 \cdot I_{RRM}$ passes through zero.
5. Q_{rr} —Area under the curve defined by I_{RRM} and t_{rr} .

Package Specification

This section shows the package specification of the APT30D60BG device.

Package Outline Drawing

The following figure illustrates the TO-247 (B) package outline of the APT30D60BG device.

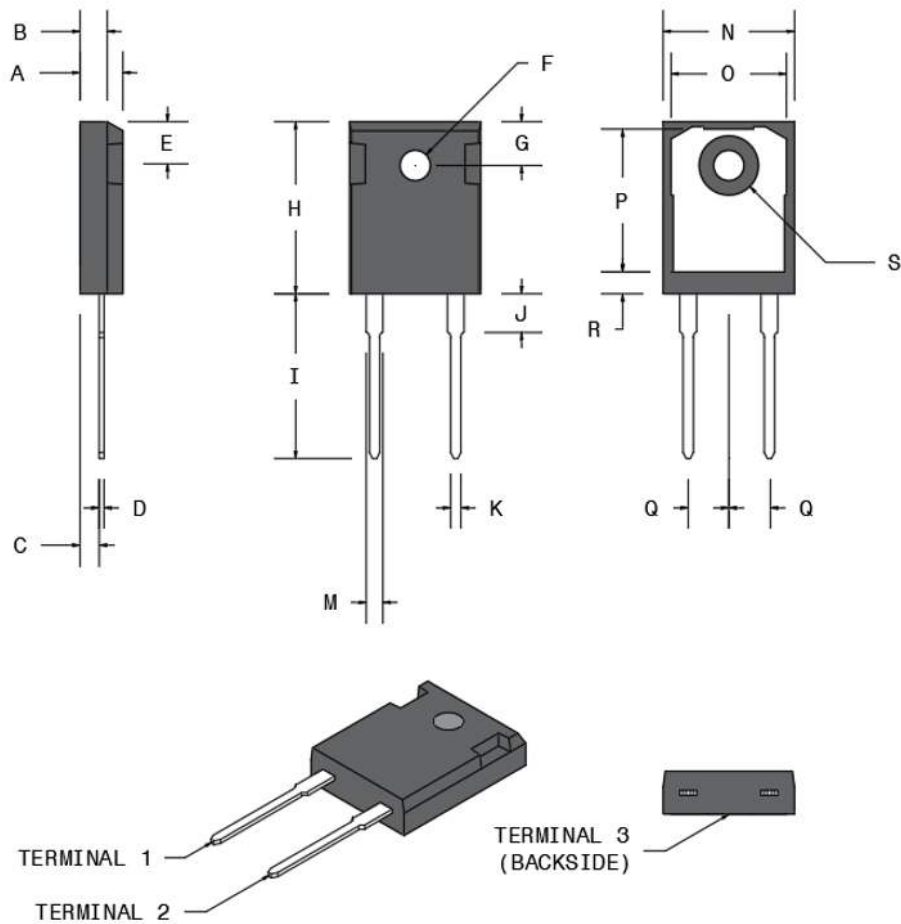


Figure 11 • Package Outline Drawing

The following table shows the TO-247 dimensions and should be used in conjunction with the package outline drawing.

Table 5 • TO-247 Dimensions

SYMBOL	MIN	MAX	MIN	MAX
	[mm]	[mm]	[INCH]	[INCH]
A	4.69	5.31	0.185	0.209
B	1.49	2.49	0.059	0.098
C	2.21	2.59	0.087	0.102
D	0.40	0.79	0.016	0.031
E	5.38	6.20	0.212	0.244
F	3.50	3.81	0.138	0.150
G	6.15 BSC		0.242 BSC	
H	20.80	21.46	0.819	0.845
I	19.81	20.32	0.780	0.800
J	4.00	4.50	0.157	0.177
K	1.01	1.40	0.040	0.055
L	2.87	3.12	0.113	0.123
M	1.65	2.13	0.065	0.084
N	15.49	16.26	0.610	0.640
O	13.50	14.50	0.531	0.571
P	16.50	17.50	0.650	0.689
Q	5.45 BSC		0.215 BSC	
R	2.00	2.75	0.079	0.108
S	7.10	7.50	0.280	0.295
TERMINAL 1	CATHODE			
TERMINAL 2	ANODE			
TERMINAL 3	CATHODE			

**Microsemi**

2355 W. Chandler Blvd.
 Chandler, AZ 85224 USA

Within the USA: +1 (480) 792-7200
 Fax: +1 (480) 792-7277

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